



Zigbee & RF4CE Template: Release August 30th, 2016

TEST REPORT

N°: 144049-691870B Version : 01

Subject Radio spectrum matters

tests according to standards:

47 CFR Part 15.247 & RSS-247 Issue 1 & RSS-Gen Issue 412

Issued to NXP Semiconductors

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FRANCE

Apparatus under test

♦ Product JN5169-001-U00-2

♦ Trade mark
NXP

♦ Serial number

♦ IC 8764A-JN5169U0V2

♦ FCC ID XXMJN5169U0V2

Test date : September 13, 2016 to September 22, 2016

Test location Fontenay Aux Roses

Composition of document 38 pages

Document issued on October 12, 2016

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LCIE

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PUBLICATION HISTORY

Version	Date	Author	Modification
01	October 12, 2016	Armand MAHOUNGOU	Creation of the document



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1. **TEST PROGRAM**

References

- 47 CFR Part 15.247
- **RSS 247 Issue 1**
- **RSS Gen Issue 4**
- KDB 558074 D01 DTS Meas Guidance v03r05
- ANSI C63.10-2013

Radio requirement:

Clause (47CFR Part 15.247 & RSS-247 Issue 1 & RSS-Gen Issue 4) Test Description Test result - Comments					
Occupied Bandwidth 🏱	☑ PASS	□ FAIL	□ NA	□ NP(1)	
6dB Bandwidth №	☑ PASS	□ FAIL	□ NA()	□ NP(1)	
Duty Cycle ₽	☑ PASS	□ FAIL	□NA	□ NP(1)	
Maximum Conducted Output Power ₽	☑ PASS	□ FAIL	□NA	□ NP(1)	
Power Spectral Density 🎘	☑ PASS	□ FAIL	□ NA	□ NP(1)	
Conducted Spurious Emission at the Band Edge 🎘	☑ PASS	□ FAIL	□ NA()	□ NP(1)	
Unwanted Emissions into Non-Restricted Frequency Bands №	☑ PASS	□ FAIL	□ NA()	□ NP(1)	
AC Power Line Conducted Emission №	☑ PASS	□ FAIL	□ NA(2)	□ NP(1)	
Unwanted Emissions into Restricted Frequency Bands 🎘	☑ PASS	□ FAIL	□ NA	□ NP(1)	
Receiver Radiated emissions 🎘	☑ PASS	□ FAIL	□ NA	□ NP(1)	
This table is a summary of test report, see conclusion of each clause of this test report for detail.					

(1): Limited program(2): EUT not directly or indirectly connected to the AC Power Public Network

PASS: EUT complies with standard's requirement FAIL: EUT does not comply with standard's requirement

NA: Not Applicable NP: Test Not Performed



2. EQUIPMENT UNDER TEST: CONFIGURATION (DECLARED BY PROVIDER)

2.1. HARDWARE IDENTIFICATION (EUT AND AUXILIARIES):

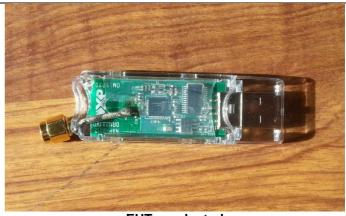
Equipment under test (EUT):

NXP JN5169-001-U00-2

Serial Number: -



EUT radiated



EUT conducted

Equipment Under Test

Auxiliary equipment used during test:

Type	Reference	Sn	Comments
Personal computer	-	-	-

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Equipment information:

Equipment information.						
Type:	☑ ZIGBEE			□RF	4CE	
Frequency band:	[2400 – 2483.5] MHz					
Number of Channel:			1	6		
Spacing channel:			5M	Hz		
Channel bandwidth:			2M	Hz		
Antenna Type:					□ Dedicated	
Antenna connector:	☐ Yes ☐ No			✓T	emporary for test	
Transmit chains:	1					
Receiver chains			1			
Type of equipment:	☐ Stand-alone		☑ Pl	ug-in	□ Combined	
Ad-Hoc mode:		Yes			☑ No	
Duty cycle:	☑ Continuous d	uty	☐ Intermi	ttent duty		☐ 100% duty
Equipment type:	✓ Produce	ction mo	odel	□ Pre	e-produ	ction model
	Tmin:		□ -20°C	□ 0°C	;	☑ -40°C
Operating temperature range:	Tnom:	:		20°C		
	Tmax:		□ 35°C	□ 55°C		☑ 85°C
Type of power source:	☐ AC power sup	ply	☑ DC power supply			□ Battery
Operating voltage range:	Vnom:		□ 120V/60Hz		☑ 3.3 Vdc	

Antenna Characteristic						
Antenna assembly	Gain (dBi)	Frequency Band (MHz)	Impedance(Ω)			
1	1.0	2440	50			



CHANNEL PLAN					
Channel	Frequency (MHz)				
Cmin: 11	2405				
12	2410				
13	2415				
14	2420				
15	2425				
16	2430				
17	2435				
Cmid: 18	2440				
19	2445				
20	2450				
21	2455				
22	2460				
23	2465				
24	2470				
25	2475				
Cmax: 26	2480				

	DATA RATE	
Data Rate (Mbps)	Modulation Type	Worst Case Modulation
0.25	O-QPSK	V



2.2. RUNNING MODE

The EUT is set in the following modes during tests:

Hardware Configuration:

- 1 sample in RF radiated mode
- 1 sample in RF conducted mode:
- Connector Type:

☑ SMA

Software Configuration:

Tx Test:

Emission: Set the EUT in permanent emissionModulation: Set the EUT in modulated mode

- Channel: Set the EUT in channel declared

- Power Setting: Set the EUT at the Highest power

Rx Test:

Reception: Set the EUT in permanent receptionModulation: Set the EUT in modulated mode

Channel: Set the EUT in channel declared

Following commands with the specific test software "CMET 4.04" are used to set the product:

-Channel Power and attenuator configuration:

Channel	Power	2.5dB Att
11	5	
18	5	
26	4	\boxtimes

2.3. EQUIPMENT LABELLING



2.4. EQUIPMENT MODIFICAT	ION	
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✓ None ☐ Modification:



3. OCCUPIED BANDWIDTH

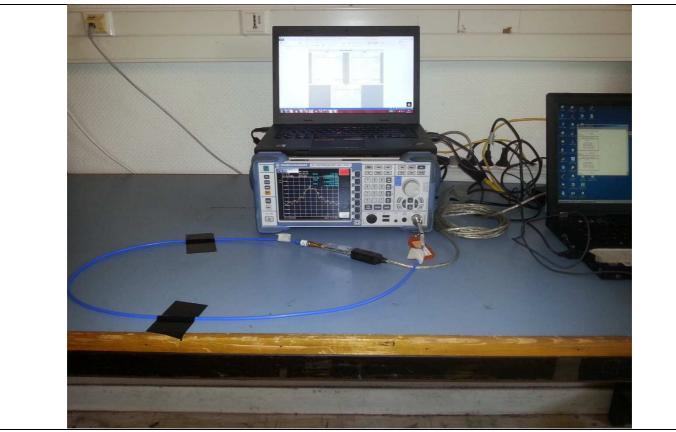
3.1. TEST CONDITIONS

Test performed by : Armand MAHOUNGOU Date of test : September 13, 2016

Ambient temperature : 26 °C Relative humidity : 41 %

3.2. TEST SETUP

- The Equipment Under Test is installed:
- ☑ On a table
- □ In an anechoic chamber
- Measurement is performed with a spectrum analyzer in:
- ☑ Conducted Method
- ☐ Radiated Method
- Test Procedure:
- ☑ RSS-Gen Issue 4 § 6.6
- ☐ ANSI C63.10 § 6.9.2



Photograph for Occupied bandwidth



3.1. **LIMIT**

None

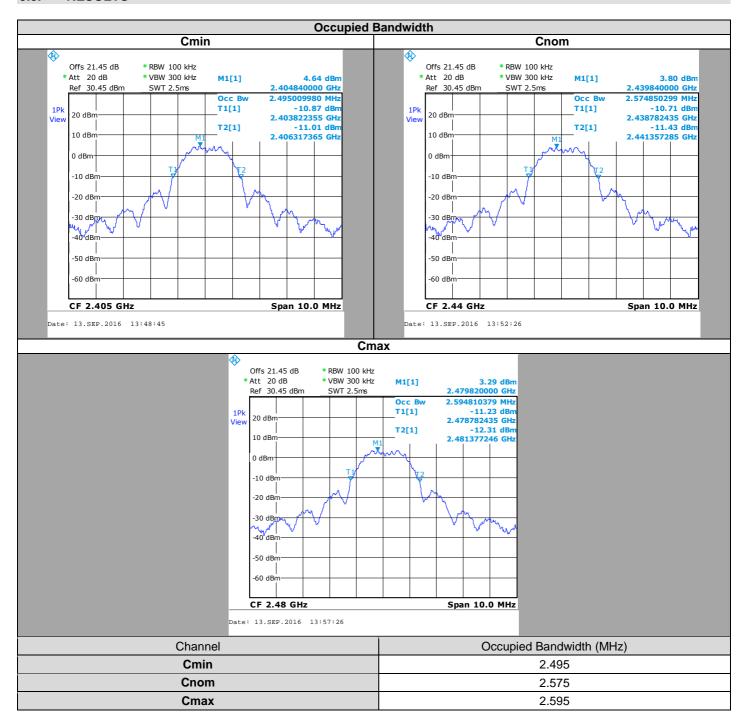
3.2. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
Spectrum analyzer	ROHDE & SCHWARZ	FSL6	A4060032	2015/04	2017/04
RF cable & 20 dB attenuator	Télédyne	920-0202-048	A5329675	2015/10	2016/10

Note: In our quality system, the test equipment calibration due is more & less 2 months



3.3. RESULTS



3.1. CONCLUSION

Occupied Channel Bandwidth measurement performed on the sample of the product **NXP JN5169-001-U00-2**, SN: -, in configuration and description presented in this test report, show levels **compliant** to the **47 CFR PART 15.247 & RSS-GEN ISSUE 4** limits.



4. 6DB EMISSION BANDWIDTH

4.1. TEST CONDITIONS

Test performed by : Armand MAHOUNGOU Date of test : September 13, 2016

Ambient temperature : 26 °C Relative humidity : 41 %

4.2. TEST SETUP

- The Equipment Under Test is installed:
- ☑ On a table
- ☐ In an anechoic chamber
- Measurement is performed with a spectrum analyzer in:
- ☑ Conducted Method
- ☐ Radiated Method
- Test Procedure:
- ☑ KDB 558074 D01 DTS Meas Guidance v03r05 § 8.1
- ☐ KDB 558074 D01 DTS Meas Guidance v03r05 § 8.2



Photograph for 6dB emission bandwidth



4.3. LIMIT

The 6dB bandwidth shall be at least 500kHz

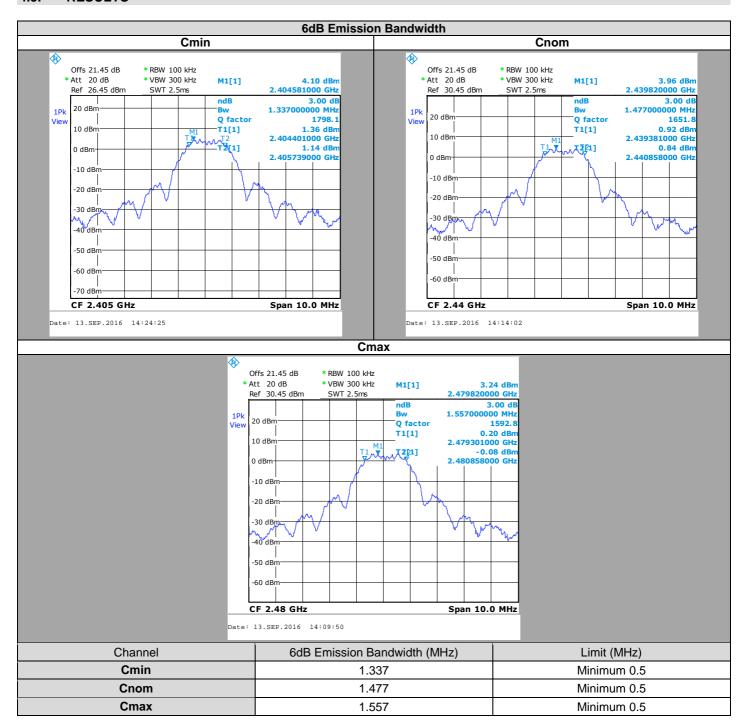
4.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
Spectrum analyzer	ROHDE & SCHWARZ	FSL6	A4060032	2015/04	2017/04
RF cable & 20 dB attenuator	Télédyne	920-0202-048	A5329675	2015/10	2016/10

Note: In our quality system, the test equipment calibration due is more & less 2 months



4.5. RESULTS



4.6. CONCLUSION

6dB Emission Bandwidth measurement performed on the sample of the product NXP JN5169-001-U00-2, SN: -, in configuration and description presented in this test report, show levels compliant to the 47 CFR PART 15.247 & RSS 247 ISSUE 1 limits.



5. MAXIMUM CONDUCTED OUTPUT POWER

5.1. TEST CONDITIONS

Test performed by : Armand MAHOUNGOU

Date of test : September 13, 2016 to September 14, 2016

Ambient temperature : 29 °C & 27 °C Relative humidity : 40 % & 42 %

5.2. TEST SETUP

- The Equipment Under Test is installed:

☑ On a table

□ In an anechoic chamber

- Measurement is performed with a spectrum analyzer in:

☑ Conducted Method

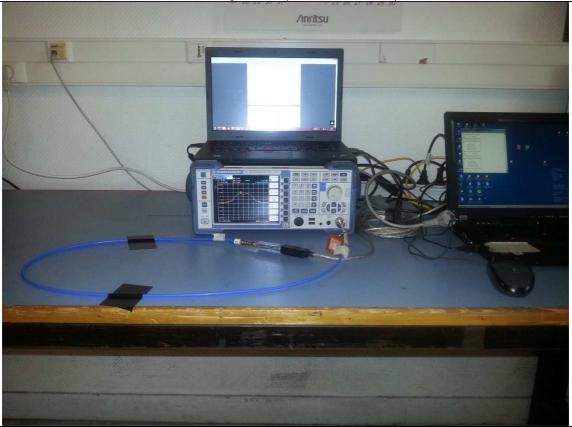
☐ Radiated Method

- Test Procedure:

☑ KDB 558074 D01 DTS Meas Guidance v03r05 § 9.1.1 (RBW≥DTS bandwidth)

☐ KDB 558074 D01 DTS Meas Guidance v03r05 § 9.2.2.2 (Method AVGSA-1)

☐ KDB 558074 D01 DTS Meas Guidance v03r05 § 9.2.2.4 (Method AVGSA-2)



Photograph for Maximum Conducted Output Power



5.3. LIMIT

Maximum Conducted Output power: 2400MHz-2483.5MHz: Shall not exceed 30dBm Limits are reduced by G-6dBi if Overall Antenna Gain above 6dBi

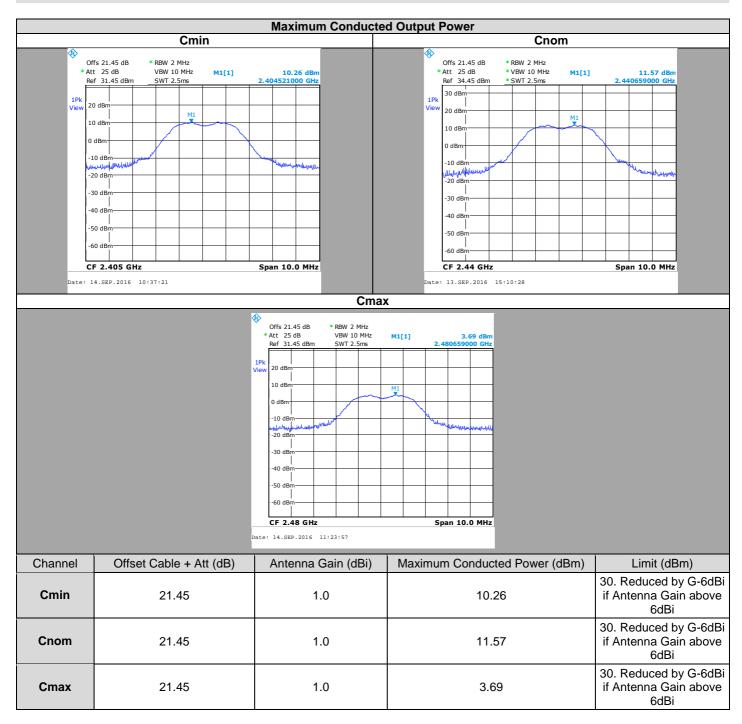
5.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL N° LCIE		Cal_Date	Cal_Due
Spectrum analyzer	ROHDE & SCHWARZ	FSL6	A4060032	2015/04	2017/04
RF cable & 20 dB attenuator	Télédyne	920-0202-048	A5329675	2015/10	2016/10

Note: In our quality system, the test equipment calibration due is more & less 2 months



5.5. RESULTS



5.6. CONCLUSION

Maximum Conducted Output Power measurement performed on the sample of the product NXP JN5169-001-U00-2, SN: -, in configuration and description presented in this test report, show levels **compliant** to the **47 CFR PART 15.247** & RSS 247 ISSUE 1 limits.



6. POWER SPECTRAL DENSITY

6.1. TEST CONDITIONS

Test performed by : Armand MAHOUNGOU

Date of test : September 13, 2016 to September 14, 2016

Ambient temperature : 28°C & 29°C Relative humidity : 41 % & 43 %

6.2. TEST SETUP

- The Equipment Under Test is installed:

☑ On a table

□ In an anechoic chamber

- Measurement is performed with a spectrum analyzer in:
- ☑ Conducted Method
- ☐ Radiated Method
- Test Procedure:
- ☑ KDB 558074 D01 DTS Meas Guidance v03r05 § 10.2 (Method PKPSD)
- ☐ KDB 558074 D01 DTS Meas Guidance v03r05 § 10.3 (Method AVGPSD-1)



Photograph for Power Spectral Density



6.3. LIMIT

Power Spectral Density: 2400MHz-2483.5MHz: Shall not exceed 8dBm/3kHz Limits are reduced by G-6dBi if Overall Antenna Gain above 6dBi

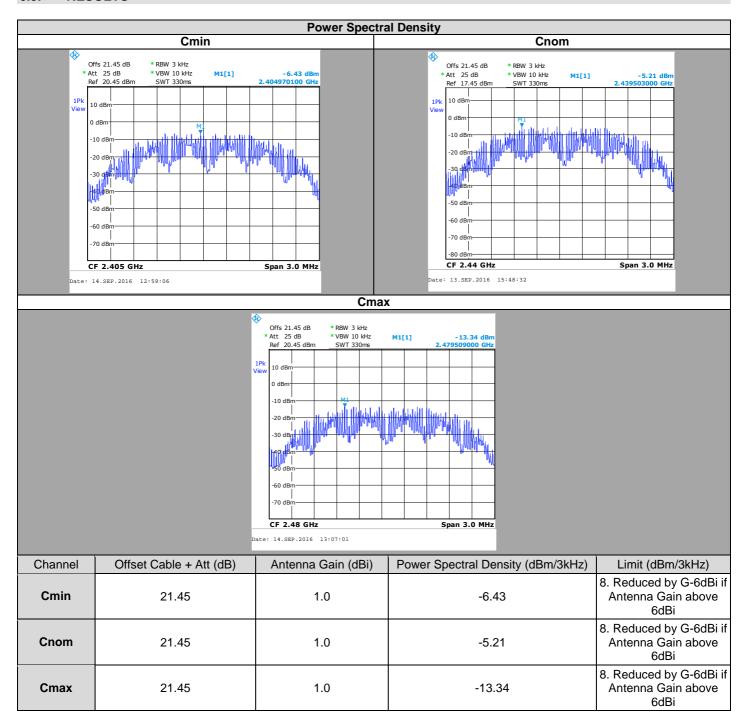
6.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
Spectrum analyzer	ROHDE & SCHWARZ	FSL6	A4060032	2015/04	2017/04
RF cable & 20 dB attenuator	Télédyne	920-0202-048	A5329675	2015/10	2016/10

Note: In our quality system, the test equipment calibration due is more & less 2 months



6.5. RESULTS



6.6. CONCLUSION

Power Spectral Density measurement performed on the sample of the product NXP JN5169-001-U00-2, SN: -, in configuration and description presented in this test report, show levels **compliant** to the **47 CFR PART 15.247 & RSS 247 ISSUE 1** limits.



7. UNWANTED EMISSIONS INTO NON-RESTRICTED FREQUENCY BANDS AT THE BAND EDGE

7.1. TEST CONDITIONS

Test performed by : Armand MAHOUNGOU Date of test : September 13, 2016

Ambient temperature : 29°C Relative humidity : 43 %

7.2. TEST SETUP

- The Equipment Under Test is installed:
- ☑ On a table
- ☐ In an anechoic chamber
- Measurement is performed with a spectrum analyzer in:
- ☑ Conducted Method
- ☐ Radiated Method
- Test Procedure:

☑ KDB 558074 D01 DTS Meas Guidance v03r05 § 11



Photograph for Unwanted Emission into non-restricted frequency bands at the band edge



7.3. **LIMIT**

All Spurious Emissions must be at least 20dB (Maximum Conduted Power) below the Fundamental Radiator Level at the Band Edge Edge "2400MHz & 2483,5MHz"

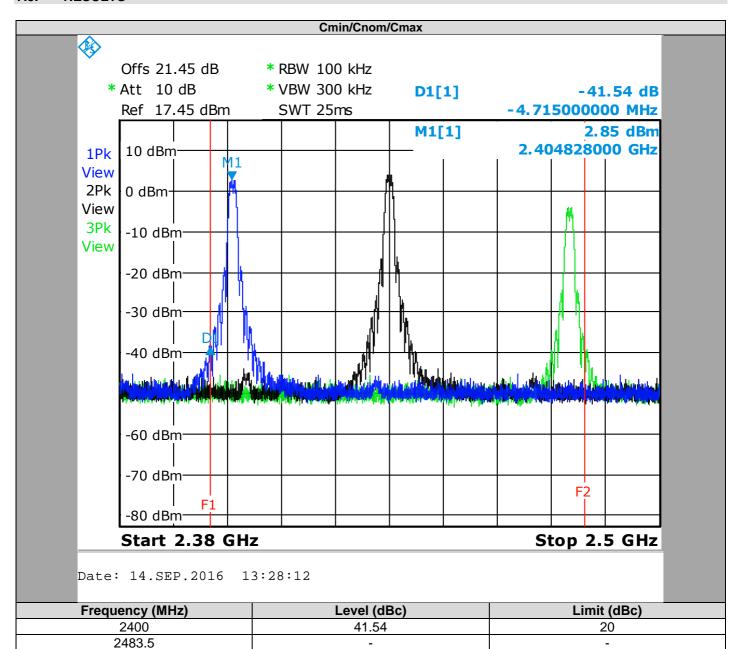
7.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL N° LCIE		Cal_Date	Cal_Due
Spectrum analyzer	ROHDE & SCHWARZ	FSL6	A4060032	2015/04	2017/04
RF cable & 20 dB attenuator	Télédyne	920-0202-048	A5329675	2015/10	2016/10

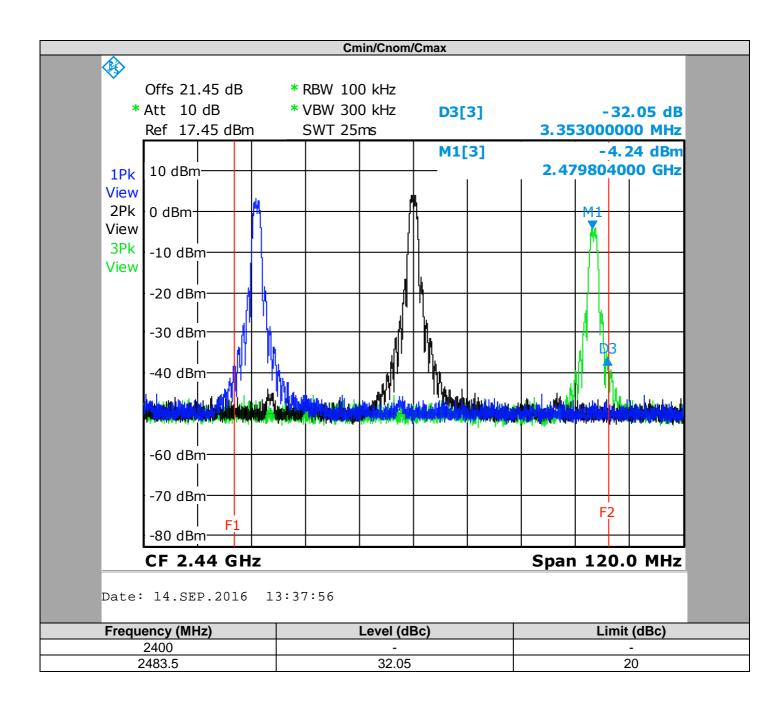
Note: In our quality system, the test equipment calibration due is more & less 2 months



7.5. RESULTS







7.1. CONCLUSION

Unwanted Emission into non-restricted frequency bands at the band edge measurement performed on the sample of the product NXP JN5169-001-U00-2, SN: -, in configuration and description presented in this test report, show levels compliant to the 47 CFR PART 15.247 & RSS 247 ISSUE 1 limits.



8. UNWANTED EMISSIONS INTO NON-RESTRICTED FREQUENCY BANDS

8.1. TEST CONDITIONS

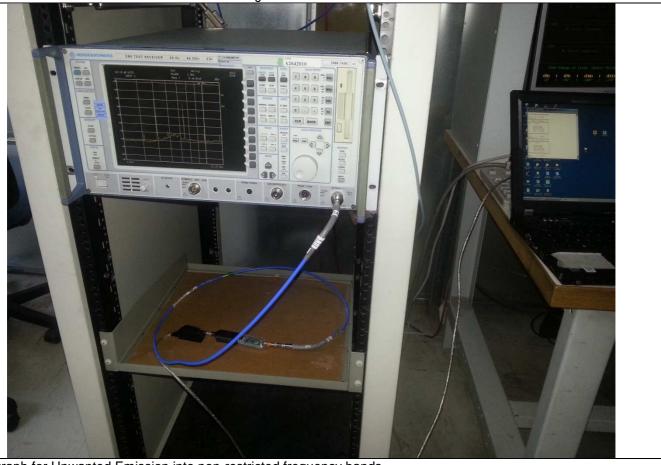
Test performed by : Armand MAHOUNGOU Date of test : September 13, 2016

Ambient temperature : 26 °C Relative humidity : 39 %

8.2. TEST SETUP

- The Equipment Under Test is installed:
- ☑ On a table
- □ In an anechoic chamber
- Measurement is performed with a spectrum analyzer in:
- ☑ Conducted Method
- ☐ Radiated Method
- Test Procedure:

☑ KDB 558074 D01 DTS Meas Guidance v03r05 § 11



Photograph for Unwanted Emission into non-restricted frequency bands



8.3. LIMIT

All Spurious Emissions must be at least 20dB (Maximum Conduted Power) below the Fundamental Radiator Level

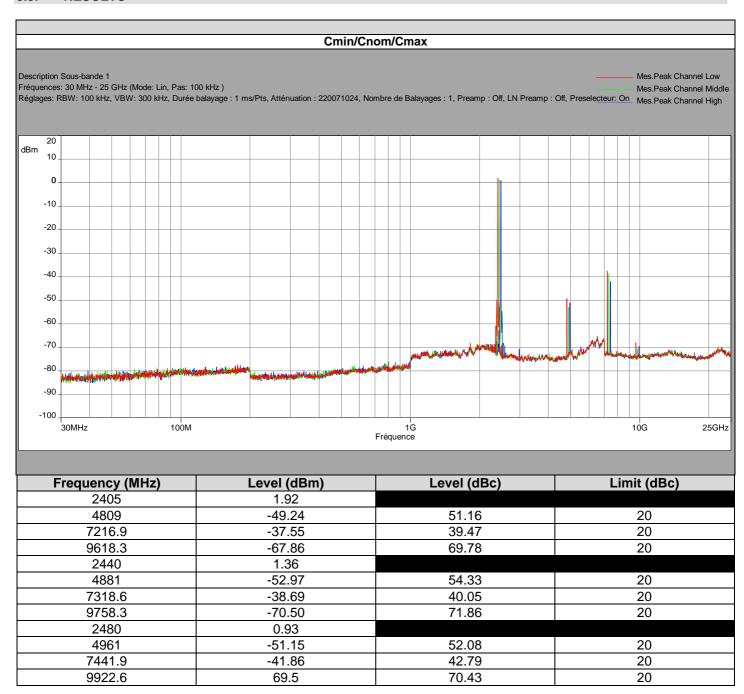
8.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
EMI receiver	ROHDE & SCHWARZ	ESI40 1088 740K40	A2642010	2016/07	2017/07
Measurement RF cable	-	Cordon 082-5454-1.5mtr	A5329624	2016/07	2018/07
Attenuator 3 dB	MINI CIRCUITS	BW-S3W2+	A7122210	2015/11	2016/11
Rejector filter 2,4GHz	=	2.45GHz	A7484048	2015/12	2016/12

Note: In our quality system, the test equipment calibration due is more & less 2 months



8.5. RESULTS



8.6. CONCLUSION

Unwanted Emission into non-restricted frequency bands measurement performed on the sample of the product NXP JN5169-001-U00-2, SN: -, in configuration and description presented in this test report, show levels **compliant** to the 47 CFR PART 15.247 & RSS 247 ISSUE 1 limits.



9. AC POWER LINE CONDUCTED EMISSIONS

9.1. TEST CONDITIONS

Test performed by : Willy DACLINAT
Date of test : September 22, 2016

Ambient temperature : 23 °C Relative humidity : 45 %

9.2. TEST SETUP

The product has been tested according to ANSI C63.10 (2013) method. The EUT is placed on the ground reference plane, at 80cm from the LISN. The distance between the EUT and the vertical ground plane is 40cm. Auxiliaries are powered by another LISN. The cable has been shorted to 1meter length. The EUT is powered through the LISN. Measurement is made with a receiver in peak mode. This was followed by a Quasi-Peak, i.e. CISPR measurement for any strong signal. If the average limit is met when using a Quasi-Peak detector, the EUT shall be deemed to meet both limits and measurement with the average detector is unnecessary. The LISN (measure) is 50Ω / 50μ H. Interconnecting cables and equipment's were moved to position that maximized emission.



Photograph for AC Power Line Conducted Emissions (Front view)



9.3. LIMIT

Quasi-Peak

0,15kHz to 0,5MHz: $66dB\mu V$ to $56dB\mu V^*$

0,5MHz to 5MHz: $56dB\mu V$ 5MHz to 30MHz: $60dB\mu V$

Average

0,15kHz to 0,5MHz: 56dBµV to 46dBµV*

0,5MHz to 5MHz: $46dB\mu V$ 5MHz to 30MHz: $50dB\mu V$

*Decreases with the logarithm of the frequency

9.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
EMI receiver	ROHDE & SCHWARZ	ESIB26	A2642021	2015/12	2016/12
Cable	CABLES & CONNECTIQUES		A5329411	2016/06	2017/06
V LISN	ROHDE & SCHWARZ	ENV216	C2320163	2016/03	2017/03

Note: In our quality system, the test equipment calibration due is more & less 2 months

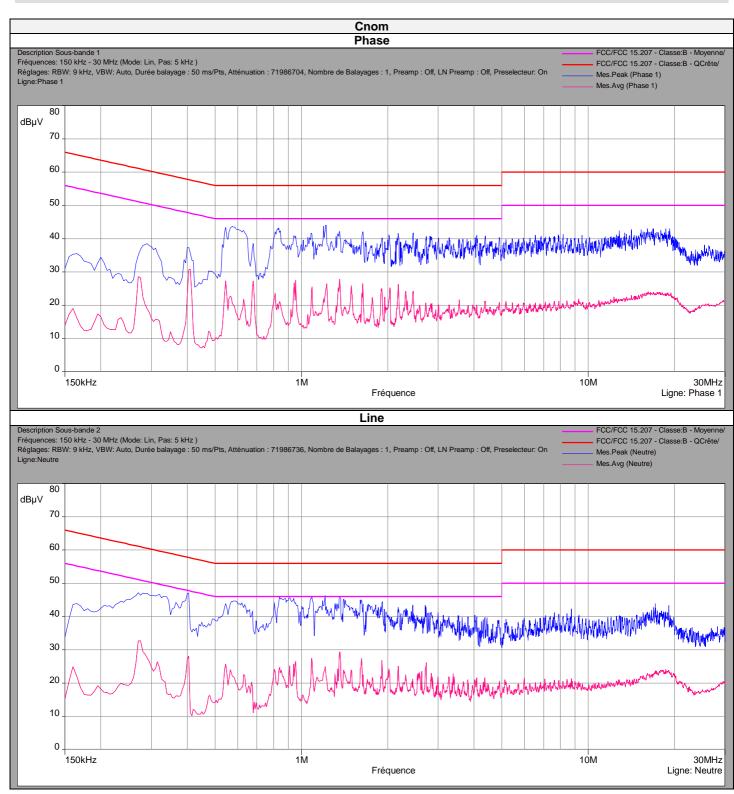
9.5. DIVERGENCE, ADDITION OR SUPPRESSION ON THE TEST SPECIFICATION

✓ None	□ Divergence:	

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9.6. RESULTS





	Phase Line							
Frequency (MHz)	Peak Level (dBµV)	Quasi-Peak Level (dBµV)	Quasi-Peak Limit (dBµV)	Average Level (dBµV)	Average Limit (dBµV)			
0.545	43.34	-	56	27.25	46			
1.36	42.19	-	56	27.82	46			
2.45	41.73	-	56	24.24	46			
4.38	40.84	-	56	21.24	46			
8.18	41.37	-	60	21.28	50			
19.23	43.02	-	60	18.94	50			

Neutral Line							
Frequency (MHz)	Peak Level (dBµV)	Quasi-Peak Level (dBµV)	Quasi-Peak Limit (dBµV)	Average Level (dBµV)	Average Limit (dBµV)		
0.405	47.12	-	57.75	28.13	47.75		
1.08	45.95	-	56	27.45	46		
1.62	45.01	-	56	27.25	46		
2.70	43.34	-	56	26.07	46		
8.74	42.26	-	60	21.41	50		
19.1	43.27	-	60	24.12	50		

9.7. CONCLUSION

Ac Power Line Conducted Emission measurement performed on the sample of the product **NXP JN5169-001-U00-2**, SN: -, in configuration and description presented in this test report, show levels **compliant** to the 47 CFR PART 15.247 & RSS 247 ISSUE 1 limits.



10. UNWANTED EMISSIONS IN RESTRICTED FREQUENCY BANDS

10.1. TEST CONDITIONS

Test performed by : Willy DACLINAT
Date of test : September 22, 2016

Ambient temperature : 23 °C Relative humidity : 44 %

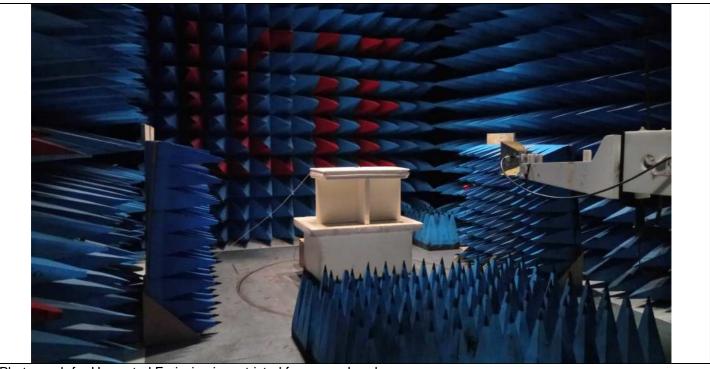
10.2. TEST SETUP

The product has been tested according to ANSI C63.10 (2013). The EUT is placed **ina semi-anechoic chamber**. Distance between measuring antenna and the EUT is **3m**. Test is performed in horizontal (H) and vertical (V) polarization with **bilog** antenna below 1GHz and with a horn antenna above 1GHz. Measurement bandwidth was 120kHz below 1GHz and 1MHz above 1GHz. The level has been maximised by the turntable rotation of 360 degrees range on the 3 axis of EUT. Antenna height search was performed from 1 to 4m. The EUT is place at 1.5m high above 1GHz and at 0.8m high under 1GHz.



Photograph for Unwanted Emission in restricted frequency bands





Photograph for Unwanted Emission in restricted frequency bands

10.3. LIMIT

Limit at 3m:

 $\begin{array}{lll} 30 \text{MHz to } 88 \text{MHz:} & 40 \text{dB}\mu\text{V/m QPeak} \\ 88 \text{MHz to } 216 \text{MHz:} & 43,5 \text{dB}\mu\text{V/m QPeak} \\ 216 \text{MHz to } 960 \text{MHz:} & 46 \text{dB}\mu\text{V/m QPeak} \\ 960 \text{MHz to } 1000 \text{MHz:} & 54 \text{dB}\mu\text{V/m Peak} \\ \text{Above } 1000 \text{MHz:} & 74 \text{dB}\mu\text{V/m Average} \\ \end{array}$

Limit at 10m:

 $\begin{array}{lll} 30 \text{MHz to } 88 \text{MHz:} & 29.5 \text{dB}\mu\text{V/m QPeak} \\ 88 \text{MHz to } 216 \text{MHz:} & 33 \text{dB}\mu\text{V/m QPeak} \\ 216 \text{MHz to } 960 \text{MHz:} & 35.5 \text{dB}\mu\text{V/m QPeak} \\ 960 \text{MHz to } 1000 \text{MHz:} & 43.5 \text{dB}\mu\text{V/m QPeak} \\ \text{Above } 1000 \text{MHz:} & 63.5 \text{B}\mu\text{V/m Average} \\ \end{array}$

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10.4. TEST EQUIPMENT LIST

DESCRIPTION	MANUFACTURER	MODEL	N° LCIE	Cal_Date	Cal_Due
EMI receiver	ROHDE & SCHWARZ	ESIB26	A2642021	2015/12	2016/12
Cable	CABLES & CONNECTIQUES	2.9MD/CSU440AA/2.9MD/2000	A5329358	2016/02	2017/02
Cable	CABLES & CONNECTIQUES	3.5MD/CSU528AA/3.5MD/4000	A5329374	2016/08	2017/08
Preamplifier	BONN Elektronik	BLNA 3018-8F305	A7080053	2016/04	2017/04
Bilog antenna	SCHWARZBECK	VULB 9160	C2040150	2016/03	2017/03
Horn antenna	EMCO	3115	C2042018	2016/08	2017/08
Rejector filter 2,4GHz	-	2.45GHz	A7484048	2015/12	2016/12
Semi anechoic chamber	SIEPEL	-	D3044008	2014/05	2017/05

Note: In our quality system, the test equipment calibration due is more & less 2 months

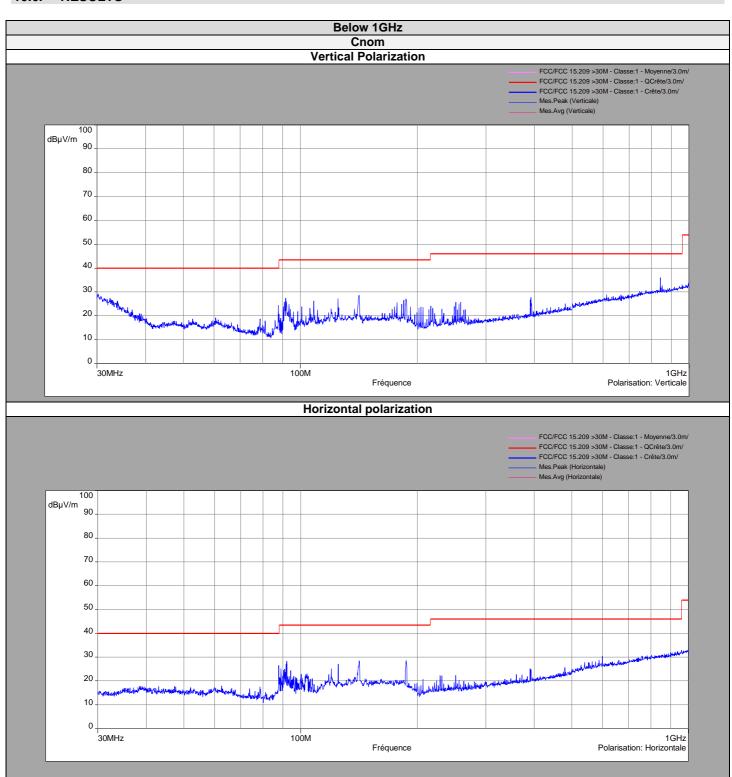
10.5. DIVERGENCE, ADDITION OR SUPPRESSION ON THE TEST SPECIFICATION

✓ None	□ Divergence:

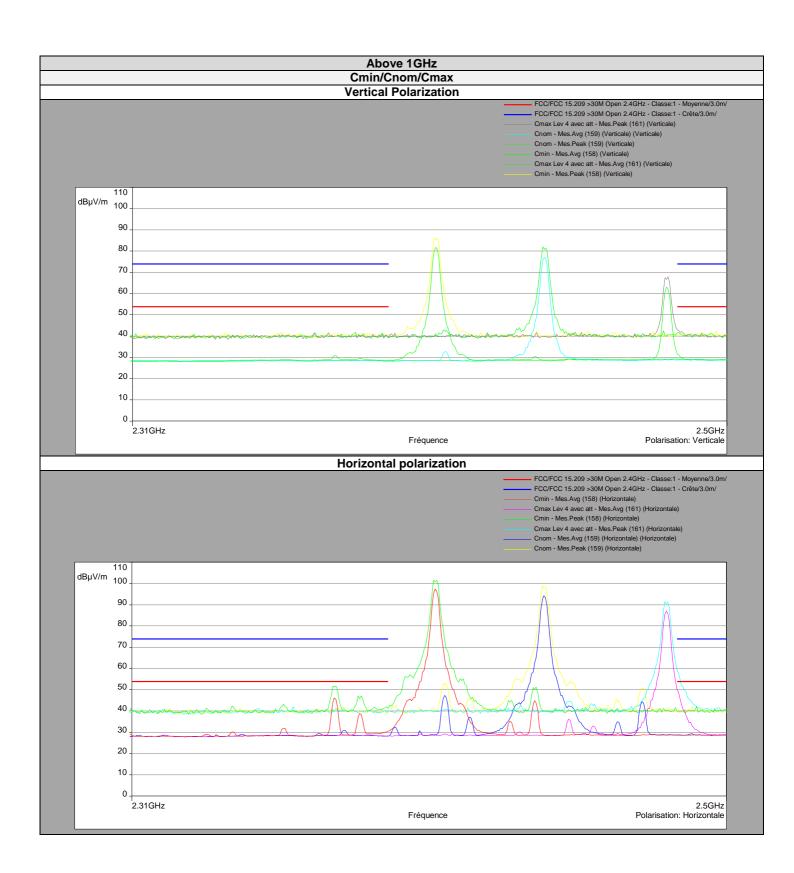
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10.6. RESULTS









		Below 1GHz		
Polarization	Frequency (MHz)	Peak Level (dBµV/m)	QPeak Level (dBµV/m)	Limit (dBµV/m)
Vertical	30.2	29.15	-	40
Vertical	91.7	27.42	-	43.5
Horizontal	92.1	28.28	-	43.5
Vertical	108.3	26.22	-	43.5
Vertical	125	29.23	-	43.5
Horizontal	125	27.10	-	43.5
Vertical	141.4	28.60	-	43.5
Horizontal	141.65	28.48	-	43.5
Vertical	186.75	27.07	-	43.5
Horizontal	186.95	28.52	-	43.5
Horizontal	390.5	25.25	-	43.5
Vertical	258.44	25.72	-	46
Vertical	391.88	27.82	-	46
Vertical	842.66	36.06	-	46

	Above 1GHz								
	Cmin/Cnom/Cmax								
Polarization	Frequency (MHz)	Duty cycle correction (dB)	Average Level (dBµV/m)	Average Limit (dBµV/m)	Peak Level (dBµV/m)	Peak Limit (dBµV/m)			
Horizontal	1440	-	37.06	54	26.63	74			
Vertical	1928	-	27.63	54	41.03	74			
Horizontal	2373	-	46.27	54	51.84	74			
Horizontal	2381	-	38.90	54	47.07	74			
Vertical	2390	-	28.23	54	40.51	74			
Horizontal	2390	-	30.58	54	41.19	74			
Vertical	2483.5	-	31.51	54	42.94	74			
Horizontal	2483.5	-	50.21	54	59.34	74			
Horizontal	3466	-	31.45	54	45.44	74			
Vertical	4809	-	39.71	54	49.89	74			
Horizontal	4818	-	36.43	54	49.14	74			
Vertical	5511	-	37.50	54	50.56	74			

10.7. CONCLUSION

Unwanted Emission in restricted frequency bands measurement performed on the sample of the product **NXP JN5169-001-U00-2**, SN: -, in configuration and description presented in this test report, show levels **compliant** to the 47 CFR PART 15.247 & RSS 247 ISSUE 1 limits.



11. UNCERTAINTIES CHART

47 CFR Part 15.209 & 15.207 Kind of test	Wide uncertainty laboratory (k=2) ±x(dB) / (Hz)/ ms	Uncertainty limit
Measurement of conducted disturbances in voltage on the AC power port (9 kHz – 150 kHz)	2,67	3.8
Measurement of conducted disturbances in voltage on the AC power port (150 kHz - 30 MHz)	2,67	3.4
Measurement of conducted disturbances in voltage on the telecommunication port. (AAN)	3,67	5.0
Measurement of conducted disturbances in current (current clamp)	2,73	2.9
Measurement of disturbance power	2,67	4.5
Measurement of radiated magnetic field from 10kHz to 30MHz in SAC V01	4,48	/
Measurement of radiated magnetic field from 10kHz to 30MHz in SAC C01	4,48	/
Measurement of radiated electric field from 30 to 1000MHz in horizontal position on the OATS (Ecuelles)	4,88	6.3
Measurement of radiated electric field from 1 to 18GHz on the Ecuelles site	5.16	/
Measurement of radiated electric field from 30 to 1000MHz in vertical position on the OATS (Ecuelles)	4,99	6.3
Measurement of radiated electric field from 30 to 1000MHz in horizontal position in SAC C01	5,08	6.3
Measurement of radiated electric field from 30 to 1000MHz in vertical position in SAC C01	5,16	6.3
Measurement of radiated electric field from 30 to 1000MHz in horizontal position in SAC V01	5,08	6.3
Measurement of radiated electric field from 30 to 1000MHz in vertical position in SAC V01	5,15	6.3
Measurement of radiated electric field from 1 to 6 GHz C01	5,1	5.2
Measurement of radiated electric field from 1 to 6 GHz V01	4,85	5.2
Measurement of radiated magnetic field from 10kHz to 30MHz on the OATS (Ecuelles)	4,48	/

The uncertainty values calculated by the laboratory are lower than limit uncertainty values defined by the CISPR. The conformity of the sample is directly established by the applicable limits values. This table includes all uncertainties maximum feasible for testing in the laboratory, whether or not made in this report